

1. Record Nr.	UNINA9910463513803321
Autore	Kaplan Beth <1950->
Titolo	Finding the Jewish Shakespeare [[electronic resource]] : the life and legacy of Jacob Gordin // Beth Kaplan
Pubbl/distr/stampa	Syracuse, N.Y., : Syracuse University Press, 2007
ISBN	0-8156-5175-9
Edizione	[1st paperback ed.]
Descrizione fisica	1 online resource (306 p.)
Collana	Judaic traditions in literature, music, and art
Disciplina	839/.123
Soggetti	Dramatists, Yiddish Dramatists, Ukrainian Dramatists, American Jewish journalists Electronic books.
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	First paperback edition, 2012.
Nota di bibliografia	Includes bibliographical references and index.
Nota di contenuto	Prologue : the playwright's funeral -- Russia -- A Russian Jew in America -- The Golden Age -- Denouement -- The Jewish King Lear -- Epilogue : Gordin's legacy to the world and to his family.
Sommario/riassunto	An inside look at the life and times of a fabled cultural figure in Yiddish theater. This biography sets out to explore the true character and creative achievements of Jacob Gordin, playwright and icon of the Yiddish stage.

2. Record Nr.	UNINA9910647244403321
Autore	Leroux Paul
Titolo	Radiation Tolerant Electronics . Volume II // Paul Leroux
Pubbl/distr/stampa	Basel : , : MDPI - Multidisciplinary Digital Publishing Institute, , 2023
ISBN	3-0365-6444-6
Descrizione fisica	1 online resource (182 pages)
Disciplina	539.2
Soggetti	Radiation
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Nota di contenuto	About the Editor vii -- Preface to "Radiation Tolerant Electronics, Volume II" ix -- Radiation-Tolerant Electronics 1 -- SEU Tolerance Efficiency of Multiple Layout-Hardened 28 nm DICE D Flip-Flops 5 -- Novel Radiation-Hardened High-Speed DFF Design Based on Redundant Filter and Typical Application Analysis 17 -- A Fully Polarity-Aware Double-Node-Upset-Resilient Latch Design 25 -- TID Sensitivity Assessment of Quadrature LC-Tank VCOs Implemented in 65-nm CMOS Technology 37 -- Radiation-Tolerant All-Digital PLL/CDR with Varactorless LC DCO in 65 nm CMOS 51 -- Novel Full TMR Placement Techniques for High-Speed Radiation Tolerant Digital Integrated Circuits 67 -- A High-Reliability Redundancy Scheme for Design of Radiation-Tolerant Half-Duty Limited DC-DC Converters 77 -- A Virtual Device for Simulation-Based Fault Injection 97 -- Comparison of the Total Ionizing Dose Sensitivity of a System in Package Point of Load Converter Using Both Component- and System-Level Test Approaches 111-- Radiation Qualification by Means of the System-Level Testing: Opportunities and Limitations -- TAISAM: A Transistor Array-Based Test Method for Characterizing Heavy Ion-Induced Sensitive Areas in Semiconductor Materials 139 -- Comparison of Total Ionizing Dose Effects in 22-nm and 28-nm FD SOI Technologies 149 -- Quantitative Research on Generalized Linear Modeling of SEU and Test Programs Based on Small Sample Data 161.
Sommario/riassunto	Research on radiation tolerant electronics has increased rapidly over the last few years, resulting in many interesting approaches to model radiation effects and design radiation hardened integrated circuits and

embedded systems. This research is strongly driven by the growing need for radiation hardened electronics for space applications, high-energy physics experiments such as those on the large hadron collider at CERN, and many terrestrial nuclear applications, including nuclear energy and safety management. With the progressive scaling of integrated circuit technologies and the growing complexity of electronic systems, their ionizing radiation susceptibility has raised many exciting challenges, which are expected to drive research in the coming decade. After the success of the first Special Issue on Radiation Tolerant Electronics, the current Special Issue features thirteen articles highlighting recent breakthroughs in radiation tolerant integrated circuit design, fault tolerance in FPGAs, radiation effects in semiconductor materials and advanced IC technologies and modelling of radiation effects.

3. Record Nr.	UNINA9910886981203321
Titolo	Business school research : excellence, academic quality and positive impact // edited by Eric Cornuel, Howard Thomas and Matthew Wood
Pubbl/distr/stampa	Abingdon, Oxon ; ; New York, NY : , : Routledge, , 2024
ISBN	1-04-001930-7 1-003-46741-5
Edizione	[1 ed.]
Descrizione fisica	1 online resource
Collana	EFMD management education
Disciplina	650.07/1
Soggetti	Business education Business schools Management - Study and teaching BUSINESS & ECONOMICS / Leadership BUSINESS & ECONOMICS / Management
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	"Global focus: Annual research volume 2, 2023"--Table of contents page.

"This second open access book in the EFMD Management Education series explores business schools' increasing focus on, and search for, meaningful societal and economic research impact. This involves, in particular, co-operation and collaboration in both knowledge creation and implementation of the findings of academic research in practice. Business schools have a critical role to play in 'rewiring' our missions for research relevance, impact and reach, and in recognising needs and addressing real issues of society and economy. With cases from a range of international business schools, the book doesn't simply highlight the need for the dominant research model in business schools to evolve, but illustrates how this can happen in practice. In so doing, it opens the discussion on how the business school can contribute in very real ways to solving global and complex challenges such as climate change, rising inequalities, international isolationism, eroding democratic systems, and the spread of fake news. These are goals that the EFMD has championed since its inception, and this book will be of value and interest to policy makers and business leaders seeking insight into how management education will be shaped to support business and wider society, as well as those working in business schools and higher education leaders. The Open Access version of this book, available at www.taylorfrancis.com, has been made available under a Creative Commons Attribution-Non Commercial-No Derivatives (CC-BY-NC-ND) 4.0 license. Funded by EFMD Global"--
